## Notice of References Cited 10/528,756 Examiner Sara W. Crane Reexamination TSUJIMURA ET AL. Page 1 of 1

Application/Control No.

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-7,098,060	08-2006	Yu et al.	438/29
*	В	US-6,485,847	11-2002	Uchida et al.	428/690
*	С	US-6,232,713	05-2001	Hamada, Yuji	313/498
	D	US-			_
	E	US-		·	
	F	US-			
	G	US-			
	н	US-			
	1	US-			
	j	US-			
	К	US-			
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	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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